

Notice of References Cited	Application/Control No. 10/561,627		Applicant(s)/Patent Under Reexamination TERECHKO ET AL.	
	Examiner Ji H. Bae		Art Unit 2115	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,493,687	02-1996	Garg et al.	712/23
*	B	US-6,301,671	10-2001	Boice et al.	713/322
*	C	US-5,996,083	11-1999	Gupta et al.	713/322
*	D	US-6,704,858	03-2004	Sugimoto, Hideki	712/228
*	E	US-6,564,331	05-2003	Joshi, Vivek	713/324
*	F	US-6,345,354	02-2002	Radivojevic et al.	712/213
*	G	US-6,718,429	04-2004	Theis, Jean-Paul	711/101
*	H	US-6,609,209	08-2003	Tiwari et al.	713/322
*	I	US-6,247,124	06-2001	Joshi et al.	712/240
*	J	US-7,206,925	04-2007	Jacobson et al.	712/225
*	K	US-5,513,363	04-1996	Kumar et al.	712/1
*	L	US-4,758,945	07-1988	Remedi, James J.	713/322
*	M	US-6,636,074	10-2003	Schulz, Jurgen M.	326/93

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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